# E lectrom agnetic w ave scattering from conducting self-a ne surfaces : A $n$ analytic and num erical study 

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#### Abstract

W e derive an analytical expression for the scattering of a scalar wave from a perfectly conducting self-a ne one dim ensional surface in the fram ew ork of the $K$ irchho approxim ation. We show that $m$ ost of the results can be recovered via a scaling analysis. W e identify the typical slope taken over one wavelength as the relevant param eter controlling the scattering process. W e com pare our predictions w ith direct num erical sim ulations perform ed on surfaces of varying roughness param eters and con $m$ the broad range of applicability of our description up to very large roughness. F inally we check that a non zero electrical resistivity provided sm all does not invalidate our results.


## I. IN TRODUCTION

A though studied for $m$ ore than fly years [ill $]$ wave scattering from rough surfaces re$m$ ains a very active eld. This constant interest com es obviously from the broad variety of its applications dom ains which include rem ote sensing, radar technology, long range radio-
astronom $y$, surface physics, etc., but from the fundam ental point of view, the sub ject has also shown a great vitality in recent years. O ne may particularly cite the badkscattering phenom ena originating either from direct $m$ ultiple scattering
 of works have also been devoted to the developm ent of reliable analytical approxim ations tīō $\{1=1 \overline{-1} 1]$. In all cases, the e cency of any analyitical approxim ation relies on a proper description of the surface roughness. In $m$ ost $m$ odels the height statistics are assum ed to be G aussian correlated. In this paper we address the question of wave scattering from rough self-a nem etallic surfaces. Since the publication of the book by B . B . M andelbrot about the fractal geom etry of nature [1] $\overline{1}$ ], scale invariance has becom e a classical tool in the description of physical ob jects. In the $m$ ore restricted context of rough surfaces, scale invariance takes the form of selfa nity. C lassical exam ples of rough surfaces obeying this type of sym $m$ etry are surfaces obtained by fracture [1] $\overline{1} \overline{1}]$ or deposition [1] $\overline{1}]$. M ore recently it was show $n$ that cold rolled alum inum surfaces [1]ī1] could also be successfully described by this form alism . W hen dealing w ith w ave scattering from rough surfaces, this scale invariance has one m ajor consequence of interest, it is responsible for long range correlations. A fter early w orks by Berry [ī̄
 very few analytical or experim ental results have been published. N otable exceptions are due to Jakem an and his collaborators $[\underline{[2} \overline{2} \overline{-1} \overline{1} \overline{2} \overline{9}]$ ] w ho w orked on di raction through self-a ne phase screens in the eighties and $m$ ore recent $w$ orks applied to the characterization of grow th surfaces scattering from a perfectly conducting selfa ne surface [3] $\left.{ }^{3}\right]$ in the K irchho approxim ation. In the follow ing we present a com plete derivation of this expression and we deduce from it analytical expressions for the w idth of the specular peak and the di use tail. These results are com pared to direct num erical sim ulations. W e show evidence that the crucial quantitative param eter is the slope of the surface taken over one w avelength.

The scattering system considered in the present work is depicted in Fig.' ${ }_{1}^{1} .1$. It consists of vacuum in the region $z>(x)$ and a perfect conductor in the region $z<\quad(x)$. The incident plane is assum ed to be the $x z-p l a n e$. This system is illum inated from the vacuum side by an s-polarized plane wave of frequency ! $=2=$. The angles of incidence and scattering respectively are denoted by 0 and , and they are de ned positive according to the convention indicated in Fig. $1 \bar{i}$.

In this paper we will be concemed with $1+1$-dim ensional self-a ne surfaces $z=(x)$. A surface is said to be self-a ne between the scales and + , if it rem ains (either exactly or statistically) invariant in this region under transform ations of the form:

$$
x!\quad x ;
$$

(1b)


F IG .1. The scattering geom etry considered in this paper.
for all positive real num bers . Here $H$ is the roughness exponent, also known as the H urst exponent, and it characterizes this invariance. This exponent is usually found in the range from zero to one. A statistical translation of the previous statem ent is that the probability $\mathrm{p}(\mathrm{x})$ of having a height di erence in the range $[$; +d ] over the (lateral) distance x is such that:

$$
\begin{equation*}
p(; x) d=p \quad{ }^{H} \quad ; \quad x d^{H} \text { : } \tag{2}
\end{equation*}
$$

Sim ple algebra based on the scaling relation ( height di erences $(x+x)$ ( $x$ ) m easured over a window of size $x$ can be written as

$$
\begin{equation*}
(x)=, ~ 1 H \quad x^{H} ; \tag{3a}
\end{equation*}
$$

and the ( $m$ ean) slope of the surface as

$$
\begin{equation*}
s(x)={\frac{V^{\prime}}{!_{1 H}}}: \tag{3b}
\end{equation*}
$$

In these equations ' denotes a length scale known as the topothesy. It is de ned as $\quad(\quad)=$ ' (ors(') = 1).

A ltematively, Eq. (

$$
\begin{equation*}
(x)=() x^{H}=s() x^{H} \text {; } \tag{4}
\end{equation*}
$$

where we use the wavelength of the scattering problem as a norm alization length. H ere ( ) and s( ) are respectively the typical height di erence and slope over one wavelength as de ned by Eqs. (i্ত) . N ote that we could have used any length scale for the norm alization, like for instance the topothesy. H ow ever, the choige $m$ ade here w as dictated by the physical problem studied. U sing sim ilar scaling argum ents one can show that the power density function of the height pro le $P(k)$ depends on the wave num ber $k$ as a power law :

$$
\begin{equation*}
P(k)=Z_{1}^{Z_{1}}(x) \exp (i k x) d x^{2} / k^{12 H}: \tag{5}
\end{equation*}
$$

In the case of a $G$ aussian height distribution, the probability $p(; x)$ reads:

The self-a ne pro le is thus fiully characterized by the roughness exponent $H$, the slope $s()$ (which is nothing but an am plitude param eter) and the bounds of the self-a ne regim e and + •
$N$ um erous $m$ ethods have been developed to estim ate these param eters (see for exam ple Ref. [[]-4] $]$ ), m ost of them use the expected power law variation of a roughness estim ator com puted over spatial ranges of varying size. This roughness estim ator can be a height standard deviation, the di erenœ between the $m$ axim um and the $m$ inim um height, etc. It is also classical to use directly the power density function of the pro le. M ore recently the wavelet analysis has beeen shown to o er a very e cient m ethod to com pute the roughness exponent of selfa ne surfaces [35].

## III. SCATTERINGTHEORY

In the follow ing we consider the scattering of $s$-polarized electrom agnetic waves from a one-dim ensional, random, $G$ aussian self-a ne surface $z=(x)$. It $w$ ill be assum ed that the low er lim it of the self-a ne regim e is sm aller than the wavelength, of the incident wave. For the present scattering system, where the roughness is one-dim ensional, the com plexity
of the problem is reduced signi cantly. The reason being that there is no depolarization and therefore the original three-dim ensional vector scattering problem reduces to a twodim ensional scalar problem for the single non-vanishing 2 nd com ponent for the electric eld, $(x ; z j!)=E_{y}(x ; z j!)$, which should satisfy the (scalar) Helm holtz equation

$$
\begin{equation*}
@_{x}^{2}+@_{z}^{2}+\frac{!^{2}}{c^{2}} \quad(x ; z j!)=0 ; \tag{7}
\end{equation*}
$$

w ith vanishing boundary condition on the random ly rough surface $\mathrm{z}=(\mathrm{x})$, and outgoing wave condition at in nity. In the far eld region, above the surface, the eld can be represented as the sum of an incident wave and scattered waves:

$$
\begin{equation*}
(x ; z j!)=0(x ; z j!)+{ }_{1}^{Z_{1}} \frac{d q}{2} R(q j) e^{i q x+i o(q ;!) z} \tag{8}
\end{equation*}
$$

where the plane incident w ave is given by:

$$
o(x ; z j!)=\exp f i k x \quad i_{0}(k ;!) z g
$$

and $R(q k)$ is the scattering am plitude. In the above expressions, we have de ned

$$
\begin{equation*}
0(q ;!)=\overline{\frac{!}{c}^{2}} q^{2} ;<0(q ;!)>0 ;=0(q ;!)>0: \tag{10}
\end{equation*}
$$

Furtherm ore, the (longitudinal) $m$ om entum variables $q$ and $k$ are in the radiative region related to respectively the scattering and incident angle by

$$
\begin{align*}
& \mathrm{k}=\frac{!}{\mathrm{c}} \sin 0  \tag{11a}\\
& \mathrm{q}=\frac{!}{\mathrm{C}} \sin \tag{11b}
\end{align*}
$$

so that the $z$-com ponents of the incident and scattering wavenum bers becom e

$$
\begin{align*}
& o(k ;!)=\frac{!}{c} \cos 0 ;  \tag{11c}\\
& o(q ;!)=\frac{!}{c} \cos : \tag{11d}
\end{align*}
$$

The $m$ ean di erential re ection coe cient (D RC), also know $n$ as the $m$ ean scattering cross section, is an experim entally accessible quantity. It is de ned as the fraction of the
total, tim e-averaged, incident energy ux scattered into the angular interval ( ; + d ). It can be show $n$ to be related to the scattering am plitude by the follow ing expression

$$
\begin{equation*}
{ }^{*}{@ R_{s}}_{@}^{@}=\frac{1}{L} \frac{!}{2 c} \frac{\cos ^{2}}{\cos 0}{ }^{D} R(q j k) J^{E}: \tag{12}
\end{equation*}
$$

H ere $L$ denotes the length covered by the self-a ne pro le asm easured along the $x$-direction, and the other quantities have been de ned earlier. The angle brackets denote an average over an ensem ble of realizations of the rough surface pro les. M oreover, the $m$ om entum variables appearing in Eq. (İ2̄) are understood to be related to the angles 0 and according to Eqs. (1īi).

W e now im pose the K irchho approxim ation which consists of locally replacing the surface by its tangentialplane at each point, and thereafter using the (local) Fresnel re ection coe cient for the local angle of incidence to obtain the scattered eld. N otioe that dealing w ith a surface whose scaling invariance range is bounded by a lower cut-o does ensure that the tangentialplane is well de ned at every point. W ithin the K irchho approxim ation the scattering am plitude can be expressed as [了ָ̄]

$$
\begin{equation*}
R(q-k)=\frac{i}{20(q ;!)}_{\mathrm{L}=2}^{\mathrm{L}=2} \mathrm{dx} \mathrm{e}^{\mathrm{iqx} i} 0(q ;!)()^{(x)} \mathrm{N}_{0}(x j!) ; \tag{13a}
\end{equation*}
$$

where $\mathrm{N}_{0}(\mathrm{xj}!)$ is a source function de ned by

$$
\begin{equation*}
\mathrm{N}_{0}(\mathrm{xj!})=2 @_{\mathrm{n}} \quad 0(\mathrm{x} ; \mathrm{zj!}) \dot{j}_{z}=(x): \tag{13b}
\end{equation*}
$$

$H$ ere $@_{n}$ denotes the (unnorm alized) norm al derivative de ned as $@_{n}={ }^{0}(x) @_{x}+@_{z}$.
 obtains an expression for the $m$ ean di erential re ection coe cient in term $s$ of the source function $N_{0}(x j!)$; the nom al derivative of the total eld evaluated on the rough surface. A fter som e straightforw ard algebra where one takes advantage of the fact that the self-a ne surface pro le function (x) has stationary increm ents, one obtains the follow ing form for the $m$ ean di erential re ection coe cient
where

$$
\begin{equation*}
(\mathrm{v})=\exp \quad \underset{\mathrm{C}}{\stackrel{!}{i}}\left[\cos +\infty \mathrm{s}_{0}\right] \quad \text { (v) ; } \tag{14b}
\end{equation*}
$$

w ith $(v)=(x)(x+v) . N$ ote that the statistical properties of the pro le function, (x), enters Eqs. $:(1-1$ earlier, Eq. ( $\overline{-}$ ), onem ay now analytically calculate the ensem.ble average contained in (v). For a $G$ aussian self-a ne surface one gets

By in Eq. (1 $\overline{1} \mathbf{i})$ ) m aking the change of variable

$$
\begin{equation*}
\mathrm{u}=\mathrm{v} \frac{!}{\mathrm{C}} \frac{\cos +\cos 0}{\mathrm{P}_{\overline{2}}} \mathrm{~s}()^{1 \mathrm{H}}{ }^{\#_{1=\mathrm{H}}} \tag{16}
\end{equation*}
$$

and letting the length of the pro le extend to in nity, L! 1 , one nally obtains the follow ing expression for the $m$ ean di erential re ection coe cient:

$$
\begin{equation*}
\frac{@ R_{s}}{@}=\frac{\left.s()^{\frac{1}{H}} a^{\left(\frac{1}{H}\right.} 1\right)}{2} \frac{\cos \frac{+0}{2}}{\cos ^{3} \frac{0}{2}} L_{2 H} \frac{P^{2} \tan \frac{0}{2}}{a^{\frac{1}{H} 1} s()^{\frac{1}{H}}} ; \tag{17a}
\end{equation*}
$$

where

$$
\begin{equation*}
a=2^{\mathrm{P}} \overline{2} \cos \frac{+0}{2} \cos \frac{0}{2} \text {; } \tag{17b}
\end{equation*}
$$

and ( $0<$
2)

$$
\begin{equation*}
\mathrm{L}(\mathrm{x})=\frac{1}{2}^{\mathrm{Z}}{ }_{1}^{1} \mathrm{dk} \mathrm{e}^{\mathrm{ikx}} e^{\mathrm{kj}}: \tag{17c}
\end{equation*}
$$

The quantity $L(x)$ is known as the centered sym $m$ etric Levy stable distribution of index
 ular values of $=;=1$ and $=200 r$ respond to the C auchy-Lorentzian and Gaussian distributions respectively, $\mathrm{L}_{1=2}$ and $\mathrm{L}_{1=3}$ can be expressed from special functions. W hen the -index in the Levy distribution $L(x)$ is low ered from its upper value $=2$ (G aussian
distribution), the resulting distribution develops a shanper peak at $x=0$ while at the sam e tim e its tails becom e fatter. It is interesting to note from Eqs. ( $\left.\overline{1}_{-1}^{\overline{1}} \bar{T}_{1}\right)$ that the wavelength,
$=2 \mathrm{c}=$ !, only com es into play through the slope $\mathrm{s}(\mathrm{)}$. The behavior of the scattered intensity is thus entirely determ ined by this typical slope s ( ) and the roughness exponent H.


FIG. 2. The $m$ ean di erential re ection coe cient, h@R $s=@ i$, vs. scattering angle, for a
 H urst exponent in allcases are $H=0: 7$ and topothesies 'are ranging from $\quad=10^{2} \quad(S(=0: 016)$ dow $n$ to $10^{6} \quad(s()=0.25)$ as indicated in the gures. The angles of incidence were (a) $0=0$ and (b) $0=0$.
 for $H$ urst exponent $H=0: 7$ and di erent values of the slope $s()$ ranging from 0:016 to
 these gures that as the am plitude param eter $s($ ) is decreased, while keeping the other param eters xed, the portion of the scattered intensity scattered di usely is reduced, while the pow er-law behavior found for the non-specular directions survives independently (w ithin single scattering) of the am ount of light scattered specularly. Furtherm ore, as the H urst exponent is decreased (results not shown), and thereby making the topography rougher at sm all scale, the m ean D RC gets a larger contribution from di usely scattered light. This is a direct consequence of the properties of the Levy distribution m entioned above.

In order to discuss the features of the $m$ ean $D R C$ which can be seen in $F$ igs. ' $1 \overline{2}$, we w ill now proceed by discussing the behavior of the specular and di use contribution to h@R ${ }_{s}=@ i$, i.e. close and far aw ay from the scattering angle $=0$ respectively.

> A. The specular contribution

W e start by considering the specular contribution to the $m$ ean di erential re ection coe cient. This is done by taking advantage of the asym ptotic expansion of the Levy distribution around zero

$$
\begin{equation*}
\mathrm{L}(\mathrm{x})=\frac{1}{-} \quad \underline{1}^{4} 4_{1}^{2} \quad \frac{3}{2} \underline{1}^{3} \mathrm{x}^{25}+\mathrm{O}\left(\mathrm{x}^{4}\right): \tag{18}
\end{equation*}
$$

By substituting this expression into Eqs. $\{\overline{1} \overline{1} \overline{-1})$ one nds that the $m$ ean DRC around the speular direction $=0$ should behave as follow s ( 1)

$$
\begin{aligned}
& \frac{@_{\mathrm{s}}{ }^{+}}{@}=0^{+} \quad \frac{\frac{1}{2 H}}{2^{\mathrm{P}} \overline{2}_{2} \mathrm{H} \quad 2^{\mathrm{P}} \overline{2} \cos 0^{\frac{1}{H^{1}} 1} \mathrm{~s}()^{1=\mathrm{H}}} 0
\end{aligned}
$$

From this expression it follow s that the am plitude of the specular peak should scale as

$$
\begin{equation*}
\frac{@_{R_{s}}^{+}}{@}=0 \quad \frac{\left(\frac{1}{2 H}\right)}{2^{\mathrm{P}} \overline{2} H^{\mathrm{H}} 2^{\mathrm{P}} \overline{2} \cos 0^{\frac{1}{\mathrm{H}} 1} \mathrm{~S}()^{1=\mathrm{H}}} ; \tag{20}
\end{equation*}
$$

and that the peaks half $w$ idth at halfm axim um, $w$, should be given by


F IG . 3. The full single scattering solution (solid line), Eqs. (1-17), for the $m$ ean di erential re ection coe cient vs. scattering angle for a perfectly conducting self-a ne surface com pared to its specular (dotted line) and di use expansions (dashed line) as given by respectively Eqs. (19 $\overline{9}$ ) and $[\underline{2} \overline{4})$. The surface param eters used were $H=0: 7$ and $v=10^{4} \quad(s()=0: 063)$, and the light w as incident nom ally onto the rough surface.

$$
\begin{equation*}
\mathrm{w}(\mathrm{H} ; \mathrm{S}() ; 0), 2^{\mathrm{u}_{\mathrm{U}}^{\mathrm{U}}} \frac{\left(\frac{1}{2 H}\right)}{\left(\frac{3}{2 H}\right)} 2^{\mathrm{p}} \overline{2} \cos 0^{\frac{1}{H} 1} \mathrm{~S}()^{1=H}: \tag{21}
\end{equation*}
$$

It is worth noting that in the above expression the $w$ idth of the specular peak depends on the wavelength via the typical slope over one wavelength $s($ ). In case of $G$ aussian correlations, there would have been no dependence on the wavelength, the peak w idth w being sim ply proportional to the ratio $=$, RMS roughness over correlation length.

In order to test the quality of the specular expansion, Eq. (1̄9), we show in Fig. ī̄ a com parison of this expression $w$ ith the fill single scattering solution obtained from Eqs. (17 $1 \bar{\eta}_{1}$ ) for a surface of roughness exponent $H=0: 7$ and of slope over the wavelength $s()=0: 063$ ( $=10^{4}$ ) in case of norm al incidence. The am plitude of the specular peak is seen to be nicely reproduced, but this expansion is only valid w thin a rather sm all angular interval around the specular direction $=0$.

It is interesting to notige that in the case of a non-zero angle of incidence, $0=0$, the specular peak is slightly shifted aw ay from its expected position $=0$ due to the presence of a non-vanishing term in Eq. ( $\left.\overline{\overline{1}} \overline{9}_{1}\right)$ linear in. In this case the apparent specular peak is located at $=0+0$, where $0\left(0 \quad \mathrm{w}^{2} \mathrm{w}\right)$ scales as

$$
\begin{equation*}
0^{\prime} \frac{2 H}{H} \frac{1\left(\frac{1}{2 H}\right)}{\left(\frac{3}{2 H}\right)} \tan 02^{\mathrm{P}} 2 \cos _{0}^{\frac{2}{H} 2} \mathrm{~S}()^{2=\mathrm{H}}=\frac{2 \mathrm{H}^{1}}{4 \mathrm{H}^{2}} \tan \mathrm{ow}^{2}(\mathrm{H} ; \mathrm{S}() \text {; o) } \tag{22}
\end{equation*}
$$

Such a shift has not, to our know ledge, been reported earlier for non selfa ne (or non fractal) surfaces. H ence, due to the selfa nity of the random surface, we predict a shift,

0, in the specular direction as com pared to its expected position at $=0 . \mathrm{N}$ otioe that this shift vanishes for a B rownian random surface ( $H=1=2$ ). M oreover, for a persistent surfaces pro le function ( $\mathrm{H}>1=2$ ) the shift is positive while it becom es negative for anti-
persistent pro le ( $\mathrm{H}<1=2$ ). Unfortunately the specular shiff 0 is probably too sm all to be observable experim entally for realizable self-a ne param eters.

## B. The di use com ponent

W e now focus on the di use com ponent to the $m$ ean di erential re ection coe cient, i.e. the region where is far away from $=0$. Now, using the expansion of the Levy distribution at in nity (the W intner developm ent) ${ }^{3} \mathbf{3} \bar{\delta}$

$$
\begin{equation*}
L(x)=\frac{(1+)}{\dot{x} x^{+} \mathfrak{j}^{+}} \sin \frac{1}{2}+0 \frac{1}{\dot{x} x^{\frac{1}{j}+2}} ; \tag{23}
\end{equation*}
$$

we get the follow ing expression for the di use com ponent of the $m$ ean D RC ( $)_{0}$ )

$$
\begin{equation*}
{\frac{@ R_{\mathrm{s}}}{@}}_{@}{ }^{+} \frac{(1+2 \mathrm{H}) \sin (\mathrm{H})}{(4)^{2 \mathrm{H} 1}} \frac{\mathrm{~s}()^{2}}{\cos 0} \frac{\cos _{0}^{+0_{0}}}{}{ }^{32 \mathrm{H}}{\frac{\sin }{2^{2}}}^{1+2 \mathrm{H}}: \tag{24}
\end{equation*}
$$

 excellent agreem ent for angular distances larger than ten degrees. M oreover, it should be noticed from Eq. $(\underline{2} \underline{2} \overline{4})$ that the $m$ ean D RC is predicted to decay as a pow er-law of exponent

12 H as we m ove aw ay from the specular direction. For sm ooth surfaces (corresponding to $s m$ all values of $s())$ this behavior results directly from a perturbation approach where the scattered intensity derived directly from the power density function of the surface. As show $n$ above, in the case ofself-a ne surfaces the latter is a pow er law of exponent $\quad 1 \quad 2 \mathrm{H}$. O ur results extend then the validity of this pow er law regin e to steeper surfaces.

## IV. SCALING ANALYSIS

It is interesting that $m$ ost of the non-trivialscaling results derived above can be retrieved via sim ple dim ensional argum ents. Let us exam ine the intensity scattered in direction ; in a naive H uyghens fram ew ork two di erent e ects will com pete to destroy the coherence of two source points on the surface i) the angular di erence separating from the specular
direction and ii) the roughness. C onsidering two points separated by a horizontal distance $x$ and a vertical distance $z$, we can de ne the retardation due to these two e ects:

$$
c_{\text {ang }}=(\sin \quad \sin 0) \times ; \quad C_{\text {rough }}=(\cos +\cos 0) z:
$$

This allows us to de ne two characteristic (horizontal) lengths ang and rough of the scattering system corresponding to the distances betw een two points of the surface such that $C_{\text {ang }}$ and $C_{\text {rough }}$ are equal to the wavelength . Taking into account the self-a ne character of the surface, we get:

$$
\text { ang }=\frac{}{\sin \sin _{0}} ; \quad \text { rough }=\frac{}{(\cos +\cos 0)^{1=H}} S()^{1=H}:
$$

T he coherence length on the surface depends on the relative $m$ agnitude of these two characteristic lengths. For scattering angles close to the specular direction, we have rough ang and for large scattering angles ang rough and the di use tail is controlled by the angular distance to the specular direction. In general we can evaluate the com petition of these two e ects and their consequences on the scattering cross-section by the sim ple ratio of the two characteristic lengths:

$$
=\frac{\text { rough }}{\text { ang }}=\frac{\sin \sin _{0}}{(\cos +\cos 0)^{1=H}} \mathrm{~S}()^{1=H}:
$$

W e can then describe our scattering system with this unique variable which takes into account the incidence and scattering directions, the roughness param eters of the surface and the wavelength. A direct application is the determ ination of the angular width $w$ of the specular peak. T he transition betw een the specular peak and the di use tail is sim ply de ned by $=1$ which leads to:

$$
\mathrm{w}^{\prime}[2 \mathrm{~s}()]^{1=\mathrm{H}}(\cos 0)^{1=\mathrm{H} \quad 1}
$$

which is identical to the exact result (2̄11) apart from a num erical constant. A ssum ing that $m$ ost of the intensity is scattered within the specular peak, we obtain via the energy conservation

$$
\frac{@_{R_{s}}^{+}}{@}=0, \frac{1}{\mathrm{~W}},[\mathrm{Ls}()]^{1=\mathrm{H}}(\operatorname{OOS} 0)^{11=\mathrm{H}}
$$

Forgetting the num erical constants, we can thus rew rite the scattering cross-section as

$$
\frac{@_{R_{s}}^{+}}{@}=\frac{(\mathrm{Cos} 0)^{11=H}}{\mathrm{~s}()^{1=H}}()
$$

W hen approaching the specular direction we note that ang diverges whereas rough saturates at a nite value independent on the angular direction. In this specular direction, the scattering process is thus controlled by only the latter length and does not depend on the ratio

$$
=\text { rough }^{=} \text {ang } \cdot \text { This im poses: }
$$

$$
()^{\prime} 1 ; \quad(\quad 1):
$$

The argum ent being inversely proportional to the quantity $s()^{1=H}$ which is nothing but a roughness am plitude param eter, the behavior of for large argum ents can be found by $m$ atching our expresion $w$ ith the lim it of very $m$ ooth surfaces. In this lim it a sim ple perturbation approach leads to:

$$
\left.{ }^{\star} \varrho_{\mathrm{R}_{\mathrm{s}}}^{+} / \mathrm{P} \frac{2}{(\sin } \sin 0\right) ;
$$

where $P$ is the power density function of the height pro $l e$. In the case of a selfa ne pro le of roughness exponent $H$, we have $P(k) / k^{12 H}$. O ne can check that this can only be consistent w ith the sam e power law behavior for :

$$
() / 12 \mathrm{H} ; \quad(\quad 1):
$$

## V.NUMERICALSIM ULATION RESULTSAND D ISCUSSION

The results obtained in the previous sections were all based on the $K$ irchho approxi$m$ ation, and will therefore only be accurate in cases where single scattering is dom inating. In this section, how ever, we will therefore no longer restrict ourselves to single scattering,
but instead include any higher order scattering process. This is accom plished by a rigorous num erical sim ulations approach which w illbe described below . T his approach w illalso serve as an independent check of the correctness of the analytic results $\left(\underline{1} \overline{-1} \bar{i}_{1}\right)$, and the results that can be derived thereof. Furtherm ore, it w ill also provide valuable insight into which part of param eter space is dom inated by single scattering processes, and thus where form ulae (171) can be used w ith con dence.

The rigorous num erical sim ulation calculations for the $m$ ean di erential re ection $c o-$ e cient were perform ed for a plane incident s-polarized wave scattered from a perfectly conducting rough self-a ne surface. Such sim ulations were done by the now quite standard extinction theorem technique $[\hat{\text { Nä }} \overline{-1}]$. This technique am ounts to using $G$ reen's second integral identity to write dow n the follow ing inhom ogeneous Fredholm equation of the second kind


$$
N(x j!)=2 N_{0}(x j!) \quad 2 P^{z} d x^{0} @_{n} G_{0}\left(x ; z \dot{x}^{0} ; z^{0}\right) j_{z}=\left(x^{0}\right) N\left(x^{0} j!\right):
$$

In this equation

$$
\begin{equation*}
N(x j!)=@_{n}(x ; z j!) j_{z=(x)} ; \tag{25.b}
\end{equation*}
$$

where $\varrho_{\mathrm{n}}=\quad{ }^{0}(\mathrm{x}) \varrho_{\mathrm{x}}+\varrho_{\mathrm{z}}$ is the (unnorm alized) norm al derivative of the totalelectric eld $=\mathrm{E}_{\mathrm{y}}$ evaluated on the random ly rough self-a ne surface, $\mathrm{N} 0(\mathrm{x} j!)$ hasbeen de ned earlier as the norm al derivative of the incident eld, and $P$ is used to denote the principle part of the integral. $M$ oreover, $G_{0}\left(x ; z^{0} x^{0} ; z^{0}\right)$ is the (two-dim ensional) free space $G$ reens function de ned by

$$
\begin{equation*}
\mathrm{G}_{0}\left(\mathrm{x} ; \mathrm{z} \dot{y^{\prime}} \mathrm{x}^{0} z^{0}\right)=\mathrm{i} \mathrm{H}_{0}^{(1)} \frac{!}{\mathrm{C}} \dot{\mathrm{j}} \quad \mathrm{r} j ; \tag{25c}
\end{equation*}
$$

where $r=(x ; z), r^{0}=\left(x^{0} ; z^{0}\right)$ and $H_{0}^{(1)}(x)$ denotes the 0 th order $H$ ankel function of the rst kind [îin 1 the norm alderivative of the total eld on the random surface, the scattering am plitude can easily be calculated, and from there the $m$ ean di erential re ection coe cient. It should be
notioed that the $K$ irchho approxim ation used in the previous section to obtain the analytical results $(\underline{1} \overline{1} \overline{-1})$, is obtained from by Eq. ( $\left.\overline{2} \overline{5} \overline{\mathrm{z}})^{\prime}\right)$ by neglecting the last (integral) term that represents $m$ ultiple scattering. By using a num erical quadrature schem e [A프극, the integral equation, Eq. (205aial), can be solved for any given realization of the surface pro le (x). From the know ledge of $N$ ( $x j$ !) one $m$ ight then easily calculate the $m$ ean $D R C$.

Random ly rough $G$ aussian self-a ne surfaces of given $H$ urst exponent were generated
 G aussian random uncorrelated num bers by a decaying power-law lter ofexponent $\quad \mathrm{H} \quad 1=2$ and thereafter transform ing this sequence into real space. The topothesis (or slope) of the surfaces were then adjusted to the desired values, `, by taking advantage of Eq. (З了̄). . This is done by rst calculating the topothesy, 'o, of the original surface over its total length and thereafter rescaling the pro le by $\left({ }_{0}={ }^{\prime}\right)^{1} \mathrm{H}$, where ' is the desired topothesy. In order to having enough statistical inform ation to be able to calculate a well-de ned topothesy ' 0 , we in fact used a w indow size slightly sm aller than the total length of the surface.


FIG.4. A com parison plotted in (a) linear- and (b) linear-log scale, of the $m$ ean di erential re ection coe cient h@R $s=@$ i vs. scattering angle for a perfectly conducting self-a ne surface obtained by a rigorous num erical sim ulations approach (solid lines), and therefore including allpossiblem ultiple-scattering processes, and the single-scattering results obtained from Eqs. [1ָ그) (dashed lines). The surface param eters were $H=0: 7$ and ${ }^{`}=10^{4} \quad(s()=0: 063)$ with $=612: 7 \mathrm{~nm}$. The angles of incidence for the light were 0 and 50 as indicated in the gure.

By the $m$ ethods just described, we have perform ed rigorous num erical sim ulations for the $m$ ean di erential re ection coe cient, h@R ${ }_{s}=@ i$, in the case of a $s$-polarized plane incident wave of wavelength $=2 \mathrm{c}=!=612: 7 \mathrm{~nm}$ that is scattered from a perfectly conducting selfa ne surface characterized by the H urst exponent, H , and the topothesy '. For all sm ulation results shown, the length of the surface was $L=100$, and the spatial discretization length was $x^{\prime}=10$. All sim ulation results presented were averaged over $\mathrm{N}=1000$ surface realizations (or m ore). Furtherm ore, in order to check the quality of the num erical sim ulations, both reciprocity and unitarity were checked for all sim ulation results. It was found for all cases considered that the reciprocity was satis ed w ithin the noise level of the calculations, while the unitarity w as ful led w ithin an error of a fraction of a percent.

In Figs. 'ī' the $m$ ean di erential re ection coe cients for a surfaces characterized by the param eters $\mathrm{H}=0: 7$ and ${ }^{`}=10^{4} \quad(\mathrm{~s}()=0: 063)$ are presented. The angles of incidence of the light were $0=0$ and 50 as indicated in the gures. The solid lines represents the num erical ( $m$ ultiple-scattering) sim ulation results while the dashed lines are the (singlescattering) prediction of Eqs. (1]-1 $\overline{1})$. A s can be seen from Fig.' good between the analytic results and those obtained from the num erical sim ulations. To allow a better com parison for large scattering angles we present in $F$ ig. 'īhb the results of Fig. İa, but now in a linear-log scale. From this gure it is apparent that for the largest scattering angles there are som e disagreem ents between the analytic and num erical results. The analytic results tend to overestim ate the $m$ ean D RC in these regions. This discrepancy stem $s$ from the fact that $m$ ultiple scattering is not included in the analytical results. P art of the light that according to single scattering would have been scattered into large scattering angles are now due to m ultiple scattering processes, scattered back into sm aller


FIG. 5. The same as Figs. (single scattering results), but now using a rigorous num erical sim ulation approach (see text for details) that incorporate all higher order scattering processes.


F IG . 6. The specular peak amplitude, h@R ${ }_{s}=@ i j_{=}$, and its half $w$ idth at half $m$ axim um, $\mathrm{w}(\mathrm{H} ;=$; 0 ) as a function of the topothesy '. The angle of incidence w as in both cases $0=0$. T he solid lines are analytical results obtained from Eqs. ( $\left.\underline{2}_{\mathbf{2}}^{\mathbf{O}}\right)$ and $\left.\underline{(\underline{1} \overline{1}} \overline{1}\right)$ respectively, while the circles (am plinudes) and the squares (w idths) are obtained from the num erical sim ulations results shown in Fig.
angles. This results in $s m$ aller values for h@ $R_{s}=@$ i for the largest scattering angles. Since the unitarity condition, $\begin{array}{r}R=2 \\ =2\end{array} Q_{s}=@$ i $d=1$, is satis ed for a perfectly re ecting surface, this large angle reduction of the $m$ ean D R C has to be com pensated by an increase for other scattering angles. In the case of norm al incidence ( $0=0$ ) say, this increase can be seen in the region around j j 25 where the num erical sim ulation results are bigger then the
corresponding single-scattering analytical results. The sam e behavior can be observed for an angle of incidence of 50 .

W egive in $F$ igs.'5, the num ericalsim ulation results for ve di erent values of the topothesy ranging from $\quad=10^{6} \quad\left(S(=0: 016)\right.$ up to $10^{2} \quad(s()=0: 25)$. These m ultiple-scattering results should be com pared to the results of $F$ igs. 'ī1 which show the corresponding curves obtained from Eqs. (1-1̄). The roughness exponent used in the sim ulations leading to the results of F igs. '5i-1 w as in all cases $\mathrm{H}=0: 7$, while for the angles of incidence we used $0=0$
 length of the surface, $L=100$, was according to Eq. ( $(\underset{-1}{ }(\underline{1})$ ranging from $(\mathrm{L})=0: 4$ for the sm allest topothesy up to as large as 6:3 for the largest. The fact that we did not really use the total length, L, during the surface generation when adjusting the topothesy, but instead a slightly sm aller fraction of this length, did not seem to a ect the height standard deviation to a large degree. In fact it was found num erically that the RM S-heights of the generated surfaces were only a few peroent lower then the one obtained from using Eq. (了) and we w ill therefore in the follow ing use this equation in estim ating the RM S height of the surfaces. A coording to optical criterion these surface roughness correspond to rather rough surfaces. In particular one observes from Fig. 'I, that in the case of ' $=10^{2}$ a specular peak is hard to de ne at all in the m ean D R C spectra. This is a clear indication of a highly rough surface and thus a very severe test of our theory.

To further com pare the analytic results derived earlier w th those obtained from the num erical sim ulation approach, we in Fig. i'-1 have plotted the am plitude of the specular peaks (circles) h@ $\mathrm{R}_{\mathrm{s}}=\mathrm{C} \mathrm{ij}_{=0}$, and theirwidth (squares) $\mathrm{w}(\mathrm{H} ;=$; 0 ), as obtained from the num erical sim ulation results shown in Figs.'15. The solid lines of this gure are the analytic predictions for these quantities as given respectively by Eqs. (2ַ̄̄) and ( $\overline{2} \overline{1} 1 \mathbf{1})$. A s can be seen from this gure, the analytic predictions are in excellent agreem ent $w$ ith their num erical sim ulation counterparts. In particular this con $\mathrm{m} s$ the decaying and increasing pow er-law s in topothesy of exponent $1=\mathrm{H} \quad 1$ for these two quantities respectively.

From Eqs. ( $(\overline{1} \overline{1} \overline{-})$ we observe that if we replot the $m$ ean $D R C$ tim es the inverse of the
prefactor of the Levy distribution, vs. its argum ent, all $m$ ean D RC -curves corresponding to the sam e H urst exponent should (w thin single-scattering) collapse onto one and the sam e m aster curve. This m aster curve should be the Levy distribution, $\mathrm{L}_{2 \mathrm{H}}(\mathrm{x})$, of order 2H . N otice that this data-collapse should hold true for arbitrary values for the angle of incidence and topothesy. The failure of such a data-collapse (onto $L_{2 H}$ ) indicates essential contributions from multiple-scattering e ects. The range of scattering angles where such processes are im portant can therefore be read o from such a plot. Furtherm ore, since
 $m$ ean DRC plots can be used to $m$ easure the $H$ urst exponent of the underlying self-a ne surfaces for which the light scattering data have been obtained. In order to check these predictions for our num erical sim ulations results, we present in Fig. ${ }_{-1}{ }_{1}$ such a rescaling of the data originally presented in Fig.'ish. O nly data lying to the left of the specular peak have been included, i.e. only data for scattering angles $<0=50$. As can be seen from this gure the various scattering curves nioely fall onto the $m$ aster-curve (solid line) in regions where single-scattering is dom inating. W hen


FIG.7. Rescaled version of the rigorous num erical sm ulation results shown in Fig. 1 the data corresponding to $<50$ are included. In the rescaled coordinates all data (sym bols) should within the single scattering approxim ation collapse onto a Levy distribution of order 2 H (solid line).
m ultiple scattering processes start giving a considerable contribution the scattering curves start to deviate from this $m$ aster-curve. This observation could be used in practical applications to determ ine for what regions the scattering is dom inated by single scattering processes. For the low est topothesy considered here, ${ }^{`}=10^{6}$, a power-law extends nicely over large regions of scattering angels | a signature of the di use scattering from selfa ne surfaces. A ccording to Eq. ( $\overline{2} \overline{4} \overline{4} \overline{1}$ the exponent of this power-law should be $1 \quad 2 \mathrm{H}$. A regression $t$ to the scattering curve corresponding to the topothesy ${ }^{\prime}=10^{6}$ gives $H=0: 73 \quad 0: 02$, where the error indicated is a pure regression error. The real error is of course larger. W ith the know ledge of the H urst exponent obtained from the decay of the di use tail of the m ean D RC , we m ight now, based on the am plitude of the specular peak, obtain an estim ate for the topothesy of the surface. From the num erical sim ulation result
 where we have used the value found above for the H urst exponent. These two results $t$ quite nicely w ith the values $H=0: 7$ and ${ }^{`}=10^{6}$ used in the num erical generation of the underlying selfa ne surfaces.

It should be notioed that for the num erical results presented in this paper, we have not considered topothesies sm aller then $`=10^{6}$. H ow ever, since low ering the topothesy will, as also indicated by our num erical results, favor single-scattering processes over those obtained from multiple scattering, the analytic results (1]_1 $\mathbf{1}_{1}$ ) will trivially be valid for low values of the topothesy. This has also been checked explicitly by num erical sim ulations (results not show n ).

So far in this paper we have assum ed that the $m$ etal was a perfect conductor. O bviously this is an idealization, and even the best conductors know $n$ today are not perfect conductors at opticalw avelengths. By relaxing the assum ption of the $m$ etalbeing perfectly conducting to instead being a good conductor, i.e. a realm etal, we are no longer in position to obtain a closed form solution of the scattering problem, the reason being that the boundary conditions are no longer local quantities. In this latter case we therefore have to resort to num erical calculations in any case. In order to see how well our analytic results (1ī) describe the
scattering from realm etals (in contrast to perfect conductors) we in Fig.' ${ }_{-1}$, give the $m$ ean D RC, as obtained from num erical sim ulations exponent $H=0: 7$ and topothesy ${ }^{`}=10^{4}$. W e recall that this choice for the topothesy corresponds to a rather rough surface where the R M S-heightm easured over the w hole length of the surface is (L ) 1:45. Furthem ore, the angles of incidence were $=0$ and 50 and the wavelength of the incident light was $=612: 7 \mathrm{~nm}$. At this wavelength the dielectric
 predictions from Eqs. (1]ī), and as can be seen from this gure, the correspondence is rather good. It is interesting to see that the agreem ent betw een the analyticaland num erical results is of the sam equality as the one found for the perfect conductor (see $F$ ig. .īhb). This indicates that the analytic results given by Eqs. ( $\left(\overline{1} \overline{-1} \bar{I}_{1}\right)$ are rather robust and tend to also describe w ell the scattering from a good, but not necessary perfect, re ector. Sim ulations equivalent to those reported for silver have also been perform ed for alum inum (results not shown) which has a dielectric function that is $m$ ore then three tim es higher at the wavelength ( $=612: 7 \mathrm{~nm}$ ) used here. The conclusions found above for silver also hold true for alum inum. We nd it interesting to note that such self-a ne alum inum surfaces w ere recently reported to be seen for cold rolled alum inum [17 and $\mathrm{H}=0: 50 \quad 0: 05$ for the transverse


F IG . 8. The sam e as Fig.'int , but now using a realm etal (silver) instead of a perfect conductor. $T$ he value of the dielectric constant of silver at the wavelength of the incident light ( $=612: 7 \mathrm{~nm}$ ) was "(!) $=17: 2+0: 50 i$.
and longitudinaldirection, respectively. Before closing this section it ought to be m entioned that for realm etals the num erical sim ulations approach based on Eq. ( $2 \overline{2} \bar{z} \bar{a})$, and used above, can no longer be used directly. Instead a coupled set of inhom ogeneous Fredholm integral equations of the second type have to be solved for the electric eld, which is non-zero on the surface of a realm etal, and its nom al derivative divided by the dielectric constant of the $m$ etal. D etails about this approach can be found in e.g. Ref. [ț了̄].

## VI.CONCLUSIONS

W e have considered the scattering of s-polarized plane incident electrom agnetic waves from random ly rough self-a ne m etal surfaces characterized by the roughness exponent, H , and the topothesy, ' (or slope s( )). By considering perfect conductors, we derive within the K irchho approxim ation a closed form solution for the $m$ ean di erential re ection coefcient in term sof the param eters characterizing the rough surface | the H urst exponent and the topothesy (or slope) | and the wavelength and the angle of incidence of the incident light. These analytic predictions (w ritten from a Levy distribution of index 2 H ) were com pared against results obtained from extensive, rigorous num erical sim ulations based on the extinction theorem. An excellent agreem ent was found over large regions of param eter space. F inally the analytic results, valid for perfect conductors, were com pared to num erical sim ulation results for a (non-perfectly conducting) alum inum self-a ne surface. It was dem onstrated that also in this case the analytic predictions gave quite satisfactory results even though strictly speaking they were outside their region of their validity.

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